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Thomas Kunz, Michiel F. H. Seuren

November 1997 Proceedings of the 1997 conference of the Centre for Advanced Studies on Collaborative research

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Understanding distributed applications is a tedious and difficult task. Visualizations based on process-time diagrams are often used to obtain a better understanding of the execution of the application. The visualization tool we use is Poet, an event tracer developed at the University of Waterloo. However, these diagrams are often very complex and do not provide the user with the desired overview of the application. In our experience, such tools display repeated occurrences of non-trivial commun ...

2 Programming languages for distributed computing systems

Henri E. Bal, Jennifer G. Steiner, Andrew S. Tanenbaum

September 1989 ACM Computing Surveys (CSUR), Volume 21 Issue 3

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When distributed systems first appeared, they were programmed in traditional sequential languages, usually with the addition of a few library procedures for sending and receiving messages. As distributed applications became more commonplace and more sophisticated, this ad hoc approach became less satisfactory. Researchers all over the world began designing new programming languages specifically for implementing distributed applications. These languages and their history, their underlying pr ...

3 Compositional verification of concurrent systems using Petri-net-based condensation



Eric Y. T. Juan, Jeffrey J. P. Tsai, Tadao Murata September 1998 ACM Transactions on Programming Languages and Systems (TOPLAS), Volume 20 Issue 5

Full text available: pdf(578.81 KB)

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The state-explosion problem of formal verification has obstructed its application to largescale software systems. In this article, we introduce a set of new condensation theories: IOT-failure equivalence, IOT-state equivalence, and firing-dependence theory to cope with

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1 Reliable object storage to support atomic actions Brian M. Oki, Barbara H. Liskov, Robert W. Scheifler

December 1985 ACM SIGOPS Operating Systems Review, Proceedings of the tenth ACM symposium on Operating systems principles, Volume 19 Issue 5

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2 Principles of transaction-oriented database recovery

Theo Haerder, Andreas Reuter

December 1983 ACM Computing Surveys (CSUR), Volume 15 Issue 4

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Implementation of resilient, atomic data types

William Weihl, Barbara Liskov

April 1985 ACM Transactions on Programming Languages and Systems (TOPLAS),

Volume 7 Issue 2

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A major issue in many applications is how to preserve the consistency of data in the presence of concurrency and hardware failures. We suggest addressing this problem by implementing applications in terms of abstract data types with two properties: Their objects are atomic (they provide serializability and recoverability for activities using them) and resilient (they survive hardware failures with acceptably high probability). We define what it means for abstract data types to be atomic and ...

A model for concurrency in nested transactions systems

Catriel Beeri, Philip A. Bernstein, Nathan Goodman April 1989 Journal of the ACM (JACM), Volume 36 Issue 2

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Today's standard model for database concurrency control, called serializability theory, represents executions of transactions as partial orders of operations. The theory tells when an execution is serializable, that is, when the set of operations of a transaction execute

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Fritzke, U., Jr; Ingels, P.; Mostefaoui, A.; Raynal, M.;

Parallel and Distributed Systems, IEEE Transactions on , Volume: 12 , Issue: 2, Feb. 2001

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